

# **Notice of References Cited**

Application/Control No.  
09/919,591

Applicant(s)/Patent Under Reexam  
Bendell et al.

Examiner

Ljiljana V. Ciric *JK*

Art Unit

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## **FOREIGN PATENT DOCUMENTS**

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## **NON-PATENT DOCUMENTS**

	Include, as applicable: Author, Title, Date, Publisher, Edition or Volume, Pertinent Pages
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